Search Notes



| Application/Control | No. |
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10577728

Applicant(s)/Patent Under Reexamination

SATO, HIDEO

Examiner

SHEELA C CHAWAN

Art Unit

2624

SEARCHED

| Class | Subclass | Date | Examiner |
|----------|--|---------|----------|
| 382 | 124, 126, 115, 127, 313, 314, 315, 125, 100, 254 | 1/29/09 | SCC |
| 340 | 5.52, 5.53, 5.82, 5.83, 356 | " | " |
| 600 | 160, 109, 300, 407, 178, 310, 322 | " | " |
| 348 | 68, 70, 69, 207.99, 370 | " | " |
| 250 | 208.1, | " | " |
| 348 | 65,69 | 8/1/09 | SCC |
| 600 | 109,178 | 8/1/09 | SCC |
| 359 | 197 | 8/1/09 | SCC |
| 382 | 124 | 8/1/09 | SCC |
| SEARCH - | | 8/1/09 | SCC |
| UP-DATE | | | |

SEARCH NOTES

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| Search Notes | Date | Examiner |
| SEARCH EAST AND OTHER DATA BASE, SEE THE SEARCH | 1/29/09 | SCC |
| HISTORY. | | |
| INVENTOR NAME SEARCH | II . | II . |
| SEARCH EAST AND OTHER DATA BASE, SEE THE SEARCH | 8/1/09 | SCC |
| HISTORY. | | |
| 382/124,100,115,124,151,254.ccls. | 8/1/09 | SCC |
| 600/160,109,300,407,178,309,310,322.ccls. | 8/1/09 | SCC |
| 348/61,68,70,69.ccls. | 8/1/09 | SCC |
| 359/197.CCLS. | 8/1/09 | SCC |
| SEARCH IEEE OR INSPEC DATA BASE | 8/1/09 | SCC |
| INTERFERENCE SEARCH | 8/1/09 | SCC |
| SEARCH UP-DATE. | 8/1/09 | SCC |

INTERFERENCE SEARCH

| Class | Subclass | Date | Examiner |
|-------|----------|--------|----------|
| 382 | 124 | 8/1/09 | SCC |
| 348 | 65,69 | 8/1/09 | SCC |
| 600 | 109,178 | 8/1/09 | SCC |
| 359 | 197 | 8/1/09 | SCC |

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